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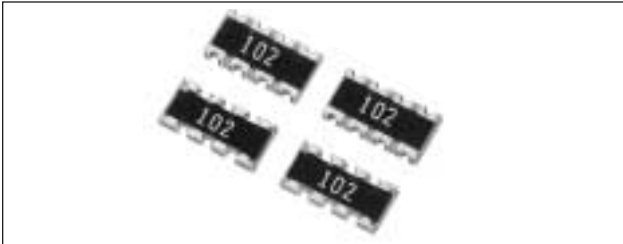
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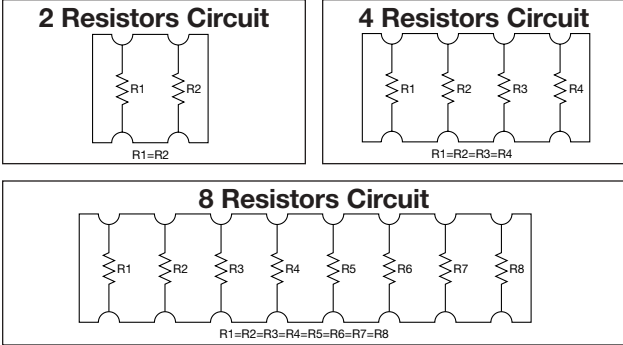
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# Chip Resistor Arrays

## CRB Series (Concave Type)



Chip Resistor Arrays have several resistor elements integrated as a single component.



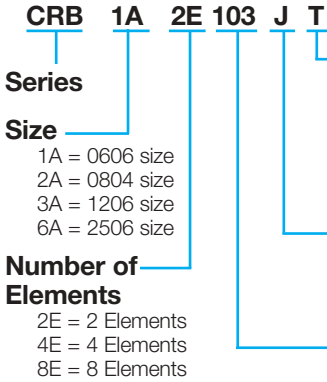
### FEATURES

- Reduction in mounting process & costs
- Save PCB space
- Reduction of inventory control costs

### APPLICATIONS

- Computer
- Hard Disk Drive
- Printer
- CD-ROM

### HOW TO ORDER



#### Packaging

- T = Paper Taping
  - CRB1A 10,000 pcs/7" reel
  - CRB2A 10,000 pcs/7" reel
  - CRB3A 5,000 pcs/7" reel
- U = Plastic Taping
  - CRB6A 4,000 pcs/7" reel

#### Resistance Tolerance

- J =  $\pm 5\%$
- G =  $\pm 2\%$
- Blank = Chip Jumper Arrays

#### Resistance Value (3 digits)

Chip Jumper Arrays = 000

### RATING

Chip Resistor Arrays	
Item	Rating
Rated Power (70°C)*	1/16W Element
Max. Working Voltage	50V
Max. Overload Voltage	100V
Resistance Value	10Ω to 2.2MΩ (CRB6A 1MΩ max.)
Tolerance	J $\pm 5\%$ (CRB6A G $\pm 2\%$ only)
Working Temperature	-55 to +125°C

Chip Jumper Arrays	
Item	Rating
Rated Current	1A
Conductive Resistance Value	50MΩ max.
Resistance Value	Zero ohms (0 $\pm$ .5 ohms)
Working Temperature	-55 to +125°C

\*Rated voltage = 50V or  $\sqrt{\text{Rated power} \times \text{Resistance value}}$ , whichever is less

### DIMENSIONS

millimeters (inches)

Code	W	L	C	d	t	a	b	P
Dim.	1.60 $\pm$ 0.15 (0.063 $\pm$ 0.006)	1.60 $\pm$ 0.20 (0.063 $\pm$ 0.008)	0.30 $\pm$ 0.20 (0.012 $\pm$ 0.008)	0.40 $\pm$ 0.15 (0.016 $\pm$ 0.006)	0.60 $\pm$ 0.10 (0.024 $\pm$ 0.006)	0.50 $\pm$ 0.15 (0.020 $\pm$ 0.006)	0.30 $\pm$ 0.10 (0.012 $\pm$ 0.004)	0.80 $\pm$ 0.10 (0.031 $\pm$ 0.004)
No Marking on chips								

Code	L	W	T	P	b	c	d	e
Dim.	2.00 $\pm$ 0.10 (0.079 $\pm$ 0.004)	1.00 $\pm$ 0.10 (0.039 $\pm$ 0.004)	0.40 $\pm$ 0.10 (0.016 $\pm$ 0.004)	0.50 typ (0.020 typ)	$\phi$ 0.15 typ ( $\phi$ 0.006 typ)	0.20 $\pm$ 0.15 (0.008 $\pm$ 0.006)	0.25 $\pm$ 0.015 (0.010 $\pm$ 0.006)	0.25 typ (0.010 typ)

Code	W	L	C	D	T	P
Dim.	1.60 $\pm$ 0.15 (0.063 $\pm$ 0.006)	3.20 $\pm$ 0.15 (0.126 $\pm$ 0.006)	0.30 $\pm$ 0.20 (0.012 $\pm$ 0.008)	0.40 $\pm$ 0.15 (0.016 $\pm$ 0.006)	0.60 $\pm$ 0.10 (0.024 $\pm$ 0.004)	0.80 typ (0.031 typ)

Code	L	W	T	P	c	d	e (top)	e (bottom)
Dim.	6.40 $\pm$ 0.20 (0.252 $\pm$ 0.008)	1.60 $\pm$ 0.20 (0.063 $\pm$ 0.008)	0.60 $\pm$ 0.10 (0.024 $\pm$ 0.004)	0.80 typ (0.031 typ)	0.30 $\pm$ 0.20 (0.012 $\pm$ 0.008)	0.40 $\pm$ 0.15 (0.016 $\pm$ 0.006)	0.50 $\pm$ 0.10 (0.020 $\pm$ 0.004)	0.40 $\pm$ 0.15 (0.016 $\pm$ 0.006)

Detailed specifications are available on request.

# Chip Resistor Arrays



## CR, CJ, CRA, CRB, CRC Series - Test Conditions

### ELECTRICAL CHARACTERISTICS

Item		Standard		Test Conditions							
		Resistor	Jumper	Resistor	Jumper						
<b>DC Resistance</b>		Within Initial Tolerance		50mΩ max.							
<b>Temperature Characteristics</b>		<table border="1"> <thead> <tr> <th>Resistance (Ω)</th> <th>TCR (ppm/°C)</th> </tr> </thead> <tbody> <tr> <td>*D, F 10 ≤ R ≤ 1M</td> <td>-100 to +100</td> </tr> <tr> <td>J, CR05 = F R &lt; 10 10 ≤ R ≤ 1M 1M &lt; R</td> <td>-100 to +600 -250 to +250 -500 to +300</td> </tr> </tbody> </table>		Resistance (Ω)	TCR (ppm/°C)	*D, F 10 ≤ R ≤ 1M	-100 to +100	J, CR05 = F R < 10 10 ≤ R ≤ 1M 1M < R	-100 to +600 -250 to +250 -500 to +300	Power Condition A (20°C, 65% RH)  Test Temperature: 25, 125(°C) $\Delta R/R = R_2 - R_1 / R_1 \times 1 / T_2 - T_1 \times 10^6$ $\Delta R/R = \text{Temp. Coefficient (ppm/°C)}$ $T_1 = 25(°C)$ $T_2 = 125(°C)$ $R_1 = T_1 \text{ Resistance at } (\Omega)$ $R_2 = T_2 \text{ Resistance at } (\Omega)$	
Resistance (Ω)	TCR (ppm/°C)										
*D, F 10 ≤ R ≤ 1M	-100 to +100										
J, CR05 = F R < 10 10 ≤ R ≤ 1M 1M < R	-100 to +600 -250 to +250 -500 to +300										
<b>Short-time Overload</b>	<b>ΔR/R</b>	±(2.0%+0.10Ω) max. of the initial value		50mΩ max.							
	<b>Visual</b>	No evidence of mechanical damage intermittent overload		(1) Apply 2.0 x rated voltage for 5 sec. (2.5 x rated voltage for Arrays) (2) Wait 30 minutes (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 100V max. CR21 = 200V max. CR32 = 400V max. CRA3A, CRB3A, CRC3A = 100V max.							
<b>Intermittent Overload</b>	<b>ΔR/R</b>	±(5%+0.1Ω) max. of the initial value		50mΩ max.							
	<b>Visual</b>	No evidence of mechanical damage		(1) Perform 10,000 voltage cycles as follows: ON (2.0 x rated voltage, 2.5 x for Arrays) 1 sec. OFF 25 sec. (2) Stabilization time 30 min. without loading (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 150V max. CR21 = 200V max. CR32 = 400V max. CRA, CRB, CRC = 100V max.							
<b>Dielectric Withstanding Voltage</b>		No evidence of mechanical damage		Apply 500 VAC for 1 min. (CR10 300 VAC) (CR05, CRA3A, CRB3A, CRC3A 300 VAC/1 sec. CR03 50 VAC/min.)							
<b>Insulation Resistance</b>		<ul style="list-style-type: none"> <li>• CR03, CJ03 = 10<sup>8</sup>Ω min.</li> <li>• CR05, CJ05 = 10<sup>8</sup>Ω min.</li> <li>• CR10, CJ10 = 10<sup>9</sup>Ω min.</li> <li>• CR21, CJ21 = 10<sup>10</sup>Ω min.</li> <li>• CR32, CJ32 = 10<sup>12</sup>Ω min.</li> <li>• CRA3A, CRB3A, CRC3A = 10<sup>9</sup>Ω min.</li> </ul>		Apply 500V DC (CR05, CRA3A, CRB3A, CRC3A 100V DC CR03 50 VDC)							



# Chip Resistor Arrays



## CR, CJ, CRA, CRB, CRC Series - Test Conditions

### MECHANICAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Terminal Strength	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Apply the load as shown: Measure resistance during load application	
	Visual	No evidence of mechanical damage after loading			
Soldering Heat Resistance	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Immerse into molten solder at 260 $\pm$ 5 $^{\circ}$ C for 10 $\pm$ 1 sec. Stabilize component at room temperature for 1 hr. Measure resistance.	
	Visual	No evidence of leaching			
Solderability		Coverage $\geq$ 95% each termination end		Immerse in Rogin Flux for 2 $\pm$ 0.5 sec. and in SN62 solder at 235 $\pm$ 5 $^{\circ}$ C for 2 $\pm$ 0.5 sec.	
Anti-Vibration Test	$\Delta R/R$	$\pm(1\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	2 hrs. each in X, Y and Z axis. (TTL 6 hrs.) 10 to 55 Hz sweep in 1 min. at 1.5mm amplitude.	
	Visual	No evidence of mechanical damage			
Solvent Resistance	$\Delta R/R$	$\pm(0.5\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Immerse in static state butyl acetate at 20 $^{\circ}$ C to 25 $^{\circ}$ C for 30 $\pm$ 5 sec. Stabilize component at room temperature for 30 min. then measure value.	
	Visual	No evidence of mechanical damage			

### ENVIRONMENTAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Temperature Cycle	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Run 5 cycles as follows: -55 $\pm$ 3 $^{\circ}$ C for 30 min. 125 $\pm$ 3 $^{\circ}$ C for 30 min. Room temp. for 10-15 min. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Low Temperature Storage	$\Delta R/R$	$\pm(2\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in -55 $^{\circ}$ C chamber without loading for 1000 $^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
High Temperature Storage	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in 125 $^{\circ}$ C chamber without loading for 1000 $^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Moisture Resistance	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in temp.: 65 $^{\circ}$ C RH90 to 95% RH chamber without loading for 1000 $^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Life Test	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Temp.: 70 $\pm$ 3 $^{\circ}$ C Voltage: (rated voltage) on 90 min. off 30 min. Duration: 1000 $^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Loading Life in Moisture	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Temp.: 40 $\pm$ 2 $^{\circ}$ C RH: 90-95% Voltage Cycle: on 90 min. (rated voltage) off 30 min. Duration: 1000 $^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			

# Packaging of Chip Component

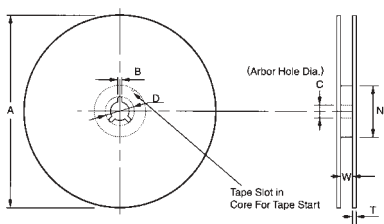


## Automatic Insertion Packaging

### TAPE AND REEL

#### REEL DIMENSIONS

millimeters (inches)



Tape Size	A Max.	B Min.	C	D Min.	N Min.	W	T Max.
8mm	178 (7)	1.50 (0.059)	13.0±0.50 (0.512±0.020)	20.2 (0.795)	50 (1.969)	10.0±1.50 (0.394±0.059)	2.50 (0.098)
	260 (10)						

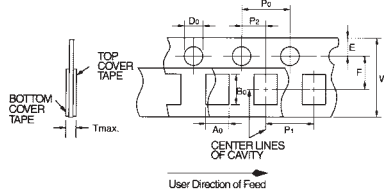
Metric dimensions will govern.  
English measurements rounded and for reference only.

millimeters (inches)

#### PUNCHED TAPE CONFIGURATION 8MM TAPE ONLY

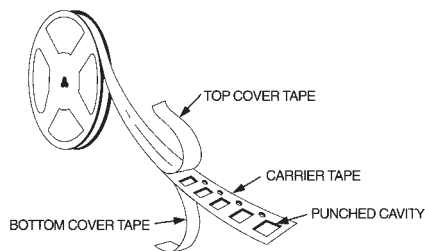
Tape Size	D <sub>0</sub>	E	P <sub>0</sub>	P <sub>2</sub>	W	F
8mm	1.50 <sup>+0.10</sup> / <sub>-0.004</sub> (0.059 <sup>+0.004</sup> / <sub>-0.000</sub> )	1.75±0.10 (0.069±0.004)	4.0±0.10 (0.157±0.004)	2.00±0.05 (0.079±0.002)	8.00±0.20 (0.135±0.008)	3.50±0.05 (0.138±0.002)

#### VARIABLE DIMENSIONS



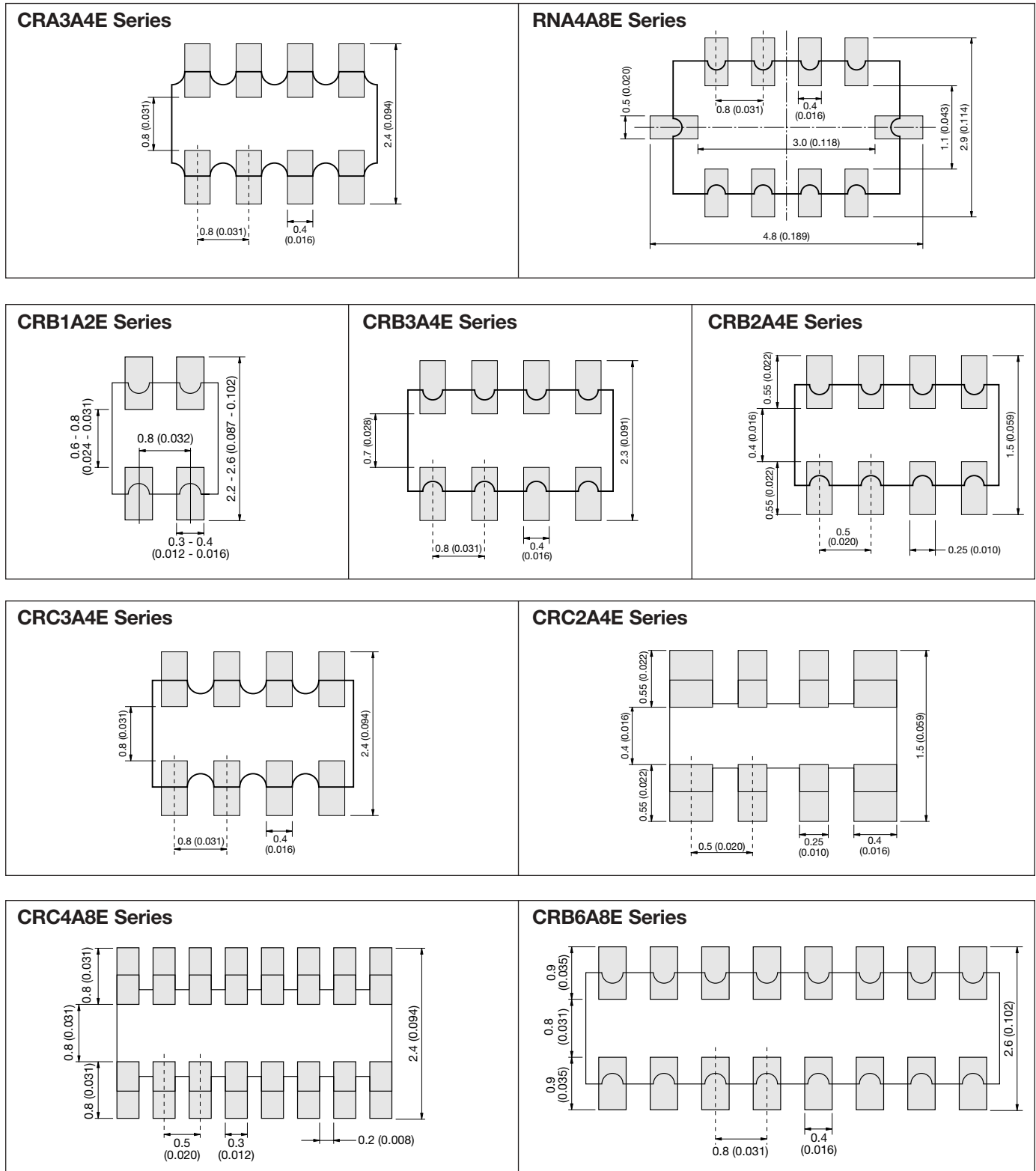
Style	P <sub>1</sub>	A <sub>0</sub>	B <sub>0</sub>	T max.
CR/CJ03 CR/CJ05	2.00±0.10 (0.079±0.004)	0.65±0.10 (0.026±0.004)	1.15±0.10 (0.045±0.004)	0.60 (0.024)
CR/CJ/FR10	4.00±0.10 (0.157±0.004) or 2.00±0.10 (0.079±0.004)	1.10±0.20 (0.043±0.008)	1.90±0.20 (0.075±0.008)	1.10 (0.043)
CR/CJ/FR21	4.00±0.10 (0.157±0.004)	1.65±0.20 (0.065±0.008)	2.40±0.20 (0.094±0.008)	
CR/CJ/FR32		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB1A		1.90±0.20 (0.075±0.008)	1.90±0.20 (0.075±0.008)	
CRA3A CRB3A CRC3A		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB2A		2.00±0.10 (0.079±0.004)	1.25±0.20 (0.049±0.008)	

#### PUNCHED CARRIER



## RECOMMENDED LAND PATTERNS IS REFERRED THE FOLLOWING FOR EXAMPLE

millimeters (inches)



## SAMPLE KIT PART NUMBERS

Part Number	Description
<b>CRJ-E6-Kit</b>	Combination 0603, 0805, 1206, 5% parts 21 values per case size 100 pcs. per value (approx.)
<b>CR05-E12-Kit</b>	0402, 5% parts 63 values 100 pcs. per value
<b>CR10J-E12-Kit</b>	0603, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR21J-E12-Kit</b>	0805, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR32J-E12-Kit</b>	1206, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR05F-E24-Kit</b>	0402, 1% parts 63 values 100 pcs. per value
<b>CR10F-E24-Kit</b>	0603, 1% parts 63 values 100 pcs. per value
<b>CR-ARRAY-E6-Kit</b>	Arrays, Various styles, CRA, CRB, CRC, RNA, 5% 13 values per style (approx.) 20 pcs. per value